Form PTO-144	19		1 DP	AND TR	NT OF COMMERCE ADEMARK OFFICE	ATTY. DOCKET NO M122-1637	o.		AL NO. 14,660	
		LIST OF ART CITED (Use several sheets	BYAPPLIC	CANTE		APPLICANT Luan C. Trun			¥ 1 .	
.:	:.		APR 3 0			FILING DATE 04/12/01		GRO 2813		
U. PATENT DOCUMENTS										
*Examiner Initial	.,	Document Number	& TRADE	MARIE	Name		Class	Subclass	Filing Date If Appropria	te .
_	744				• •					
	АВ									
	ΑC				•	· ·				
	AD									-
	AE					*				:
	AF									
	AG	-								
	АН									
	Al									
	· `AJ				<del></del>					
	AK				1					
				FOREIGN P	ATENT DOCUMENTS					
	\	Document Number	Date		Country		Class	Subclass	Translation	
	AL					<u> </u>			Yes	No
	АМ	*								
	AN	• **								
	. 40						$\Rightarrow$			
	AP			<del></del>	·					-
0.	· T	<del></del>			g Author, Title, Date, Per		1	<u> </u>		
Ale	AR	S. Walf, Silican Proce		SI Era , Vol	ame 3 - The Submicron	MOSFET, ©1995 La	tice Press, pag	es 330, 331,	366 and 367.	
10			**		· · · · · · · · · · · · · · · · · · ·					
	AS		•			<u> </u>				
					) ,					
	АТ									
			·				~	•,		
EXAMINER	h-0	S. S.	1. 10	7	DATE CONSIDERED	5/2	2/1	i i	:	
*EXAMINED	Initial if ~	ference considered whether an		<u> </u>	SIL LUDED COO. D.		1/0	7		$\dashv$
copy of this for	m with nex	ference considered, whether or re- terministration to applicant.	or digiton is th		nu mrer 009; Draw l	me through citation if	not in conform	nance and no	considered. Includ	ic .

PTO-14	TE TH	ADEMA	U.S. D PATE	DEPARTMENT OF COMMERCE NT AND TRADEMARK OFFICE	ATTY. DOCKET I	NO.	SER1/ 09/834	Shee AL NO. ,660
		LIST OF ART CITED (Use several sheet)	BY APPLICAN	π 	APPLICANT Luan C. Tran			
					FILING DATE April 21, 2001		GROU 2813	JP
	,		·	U.S. PATENT DOCUMENTS			. 1 2015	
niner itial		Document ' Number	Date	Name	!	Class	Subclass	Filing Date
D	<b>A</b>	5,851,899	12/22/1998	Weigand				
	AB	5,880,007	03/09/1999	Varian et al.			-	•
Me	AC	6,001,740	12/14/1999	Varian et al.				
Je.	AD	6,124,183	09/26/2000	Karlsson et al.				
le	AE	6,159,822	12/12/2000	Yang et al.				
	AF							
	A6-							
:	AH-					-		
	Al	· · · · · · · · · · · · · · · · · · ·						
	AJ						_	
	AK				• •	<u> </u>		·
<u> </u>		Document	Date	FOREIGN PATENT DOCUMENTS  Country	1	~	Subal	
;	·	Number		Country		Class	Subclass .	Translation Yes No
	. AL							
	_AM							
	AN							
	. AO		<u> </u>					
لــــــ	AP	·	L					
	1		OTHER REFERE	NCES (including Author, Title, Date, Pe	ertinent Pages, Etc.)		Y	
1	AO							
- 1	-			*				<del> </del>
					<u> </u>			
	AR		_					
					<del></del>		•	·
					·			
	. AS		· · · · ·		· · · · · · · · · · · · · · · · · · ·			
		]						
NER	_		1	DATE CONSIDERED	5/	. /	<del></del>	

007 0	3 2002	SEICE OF	•	•					Sheet	<u>1-of</u>
Form Program	MARK	L	IST OF ART CITED	BY APPLICAN	EPARTMENT OF COMMERCE IT AND TRADEMARK OFFICE T	ATTY. DOCKET N M122-1637	NO.	SERI, 09/834	AL NO. 1,660	
<u>-</u>		- <del></del>	(Use several sheets	if necessary)		Luan C. Tran FILING DATE	•	GRO	UP	$\dashv$
•	:				U.S. PATENT DOCUMENTS	April 12, 2001		2813		┪
*Examiner Initial			Document Number	Date	Name '		Class	Subclass	Filing Date	
Wk	٨٨	1	5,926,723	07/20/99	Wang	•				-
De	AE	3	6,420,749 B1	07/16/02	Divakaruni et al.	<u> </u>	•	:	18	
Da.	. AC	:	6,177,324 B1	01/23/01	Song et al.	-			OK OC	নূ
Ale	· · · AD	,	6,429,081 B1	08/06/02	Doong et al.	•			004	4
DOI)	AE		6,121,651	09/19/00	Furukawa et al.				CT -8 LWER 2800	3
Ale.	· AI	F	5,492,858	02/20/96	Bose et al.				ER2	
Ali	AC	,	6,323,082 B1	11/27/01	Furukawa et al.				800	
Ah	Al	,	6,156,620	12/05/00	Puchner et al.				•	
We	A	,	6,048,765	04/11/00	Wu		1			
Ale	A	,	6,351,019 B1	02/26/02	DeBrosse et al.					
DO	Al	ĸ	6,153,467	11/28/00	Wu					j
700					FOR EIGN PATENT DOCUMENT	2			T	
• •		Doi Nu	ument nber	Date	Country		Class	Subclass	Translation Yes No	
	AL									
	AM	Ŀ								
	AN AO	-								
	AP		·					,		
	· ·			OTHER REFER	ENCES (including Author, Title, Date,	Pertinent Pages, Etc.)				
r /	AQ		Wolf et al., "Silicon	Processing for the	VLSI Era" - Volume 1 - Process T	Fechnology - Second Edit	ion, © 2000,	6 pages.		•
Ale	[				•					
1	AR	:								
						,				
	AS							•	•	_
	.									
EXAMINER '	100	٠ .	801	with	DATE CONSIDER	5/a	9/0	4		
*EXAMINER:	Initial if to	eferen imunic	re considered, whether of	not eltation is in	conformance with MPEP 609; Druw	line through citation if t	not in conform	nance and not-	considered. Include cop	y,
					<u> </u>	<u> </u>		<u> </u>		

<u>Sheet 2 of</u> 3 ATTY. DOCKET NO. MI22-1637 SERIAL NO. 09/834,660 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF ART CITED BY APPLICANT APPLICANT Luan C. Tran (Use several sheets if necessary) FILING DATE April 12, 2001 GROUP U.S. PATENT DOCUMENTS Filing Date Class Subclass Date \*Examiner Initial Nitayama et al. 6,236,079 B1 05/22/01 Sunouchi et al. 09/25/01 ΑB 6,294,422 B1 Yeh 10/17/00 6,133,055 AD 6,353,242 B1 03/05/02 Watanabe et al. 03/14/00 Kepler et al. ΑE 6,037,671 02/22/00 Mori et al. AF 6,028,784 02/15/00 Sunouchi, et. al. AG 6,025,623 : Koubuchi e t al. 07/17/01 6,261,883 B1 ΑH 06/11/02 Limi et al: 6,403,484 B1 11/30/99 Hsu et al. 5,994,198 6,060,394 05/09/00 Wu FOREIGN PATENT DOCUMENTS Translation Class Subclass Country Date Document Number ΑL AM AN ΑQ ΑP OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) ٠, AQ ΑS DATE CONSIDERED EXAMINER \*EXAMINER: Initial if reference considered, whether or not citation is in of this form with next communication to applicant.



Form PTO-1449	<del>,-,=</del>		U.S. DI PATEN	EPARTMENT OF COMMERCE T AND TRADEMARK OFFICE	ATTY. DOCKET N	10.	SERI 09/83	AL NO. 4,660
LIST OF ART CITED (Use several sheets			BY APPLICAN	PLICANT APPLICANT Luan C. Tran				
				: ·	FILING DATE April 12, 2001		GRO 2813	UP
	- :.2			U.S. PATENT DOCUMENTS				
*Examiner Initial	i	Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate
Rb	AĄ	6,312,997 B1	11/06/01	Tran			•	
Pi	AB	6,411,555 B1	06/25/02	Tran				à p
Kale	,AC	5,892,707	04/06/99	Noble				C140,003, 8 1
Alo	,AD	6,171,929 B1	01/09/01	Yang et al.				06, 8
All	AE	6,391,756 B1	05/21/02	Pan et al.				TOEM ER 280
Alle	, AF.	6,423,620 B2	07/23/02	Pan et al.				ER 2
Ple	ΑG·	6,297,129 B2	10/02/01	Tran et al.		:		00
Alb	ΑĤ	5,447,884	09/05/95	Fahey et al.				
Alli	ΑĮ	5,851,900	12/22/98	Chu et al				
	AI							
	AK.				Management and American			
				FOREIGN PATENT DOCUMENT	2			
		Document Number	Date	Country		Class	Subclass .	Translation
	AL							
	AM							
	AN ,							
	. AO							
	AP							<u> </u>
			OTHER REFERE	NCES (including Author, Title, Date,	Pertineat Pages, Etc.)			
	16			- · · · · · · · · · · · · · · · · · · ·			•	
				•				
•	AR						· · · · · · · · ·	· · · · · ·
			·		<u> </u>			
•	AS		·					
			· · · · · · · · · · · · · · · · · · ·				<u></u>	· · · · · · · · · · · · · · · · · · ·
EXAMINER	1re	been Sc	LE	DATE CONSIDERI	5 S	27/	04	,
*EXAMINER: of this form wit	Inklat if i	elerence considered, whether or imunication to applicant.	not citation is.in	vaformance with MPEP 609; Draw	line through citation if r	ot in conform	ance and not	considered. Include copy



Sheet 1 of 1 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Form PTO-1449 SERIAL NO. 09/834,660 ATTY. DOCKET NO. MI22-1637 LIST OF ART CITED BY APPLICANT APPLICANT (Use several sheets if necessary) Luan C. Tran FILING DATE GROUP April 21, 2001 2813 . ; U.S. PATENT DOCUMENTS . \*Examiner Document Filing Date Number If Appropriate AA 6,545,904 B2 4/8/2003 Tran 6,492,693 B2 AB 12/10/2002 Tran .AC 6,649,461 B1 11/18/2003 Lai et al. AD 6,281,082 B1 8/28/2001 Chen et al. ΑE 5,691,215 11/25/1997 Dai'et al. AF 6,261,914 BI 7/17/2001 Divakaruni et al. AĞ 6,426,534 B1 7/30/2002 Look et al. AH 2003/0020106 A1 1/30/2003 Tran Άl AJ AK FOREIGN PATENT DOCUMENTS Document Number Date · Country Class Subclass Translation Yes No AL AM AN ΑO AP OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AQ AR EXAMINER DATE CONSIDERED \*EXAMINER: Initial if reference considered, whether or not clasion is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.